

Designer's Data Sheet
Power Field Effect Transistor
N-Channel Enhancement-Mode
Silicon Gate TMOS

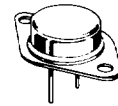
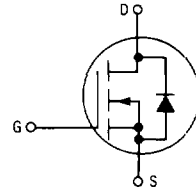
These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data — I_{DSS} , $V_{DS(on)}$, $V_{GS(th)}$ and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



MTH15N20
MTM15N20

TMOS POWER FETs
 15 AMPERES
 $r_{DS(on)} = 0.16 \text{ OHM}$
 200 VOLTS



MTM15N20
 CASE 197A-02
 TO-204AE



MTH15N20
 CASE 340-02
 TO-218AC

MAXIMUM RATINGS

Rating	Symbol	MTH or MTM	Unit
		15N20	
Drain-Source Voltage	V_{DSS}	200	Vdc
Drain-Gate Voltage ($R_{GS} = 1 \text{ M}\Omega$)	V_{DGR}	200	Vdc
Gate-Source Voltage	V_{GS} V_{GSM}	± 20	Vdc
Continuous Non-repetitive ($t_p \leq 50 \mu\text{s}$)		± 40	Vpk
Drain Current — Continuous	I_D	15	Adc
— Pulsed	I_{DM}	80	Adc
Total Power Dissipation (@ $T_C = 25^\circ\text{C}$ Derate above 25°C)	P_D	150 1.2	Watts $\text{W}/^\circ\text{C}$
Operating and Storage Temperature Range	T_J, T_{stg}	-65 to 150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case — Junction to Ambient	$R_{\theta JC}$ $R_{\theta JA}$	0.83 30	$^\circ\text{C}/\text{W}$
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Drain-Source Breakdown Voltage ($V_{GS} = 0, I_D = 0.25 \text{ mA}$) MTH15N20, MTM15N20	$V_{(BR)DSS}$	200	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0$) ($T_J = 125^\circ\text{C}$)	I_{DSS}	—	10 100	μAdc
Gate-Body Leakage Current, Forward ($V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0$)	I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse ($V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0$)	I_{GSSR}	—	100	nAdc

(continued)

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

MTH/MTM15N20

ELECTRICAL CHARACTERISTICS — continued (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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ON CHARACTERISTICS*

Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 1 mA) T _J = 100°C	V _{GS(th)}	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance (V _{GS} = 10 Vdc, I _D = 7.5 Adc)	r _{DS(on)}	—	0.16	Ohm
Drain-Source On-Voltage (V _{GS} = 10 V) (I _D = 15 Adc) (I _D = 7.5 Adc, T _J = 100°C)	V _{DS(on)}	— —	3 2.4	Vdc
Forward Transconductance (V _{DS} = 15 V, I _D = 7.5 A)	g _{FS}	4	—	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = 25 V, V _{GS} = 0, f = 1 MHz)	C _{iss}	—	2000	pF
Output Capacitance		C _{oss}	—	700	
Reverse Transfer Capacitance		C _{rss}	—	200	

SWITCHING CHARACTERISTICS* (T_J = 100°C)

Turn-On Delay Time	(V _{DD} = 25 V, I _D = 0.5 Rated I _D R _{gen} = 50 ohms) See Figures 13 and 14	t _{d(on)}	—	60	ns
Rise Time		t _r	—	300	
Turn-Off Delay Time		t _{d(off)}	—	220	
Fall Time		t _f	—	250	
Total Gate Charge	(V _{DS} = 0.8 Rated V _{DSS} , I _D = Rated I _D , V _{GS} = 10 V) See Figure 12	Q _g	60 (Typ)	75	nC
Gate-Source Charge		Q _{gs}	35 (Typ)	—	
Gate-Drain Charge		Q _{gd}	25 (Typ)	—	

SOURCE DRAIN DIODE CHARACTERISTICS*

Forward On-Voltage	(I _S = Rated I _D V _{GS} = 0)	V _{SD}	1.5 (Typ)	2.1	Vdc
Forward Turn-On Time		t _{on}	Limited by stray inductance		
Reverse Recovery Time		t _{rr}	450 (Typ)	—	ns

INTERNAL PACKAGE INDUCTANCE (TO-204)

Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)	L _d	5 (Typ)	—	nH
Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad)	L _s	12.5 (Typ)	—	

INTERNAL PACKAGE INDUCTANCE (TO-218)

Internal Drain Inductance (Measured from screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)	L _d	4 (Typ)	—	nH
		5 (Typ)	—	
Internal Source Inductance (Measured from the source lead 0.25" from package to center of die)	L _s	10 (Typ)	—	

*Pulse Test: Pulse Width ≤ 300 μs. Duty Cycle ≤ 2%.

TYPICAL ELECTRICAL CHARACTERISTICS

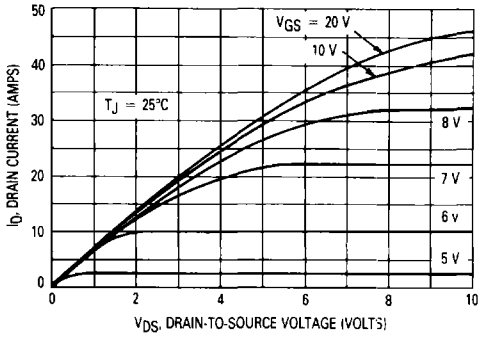


Figure 1. On-Region Characteristics

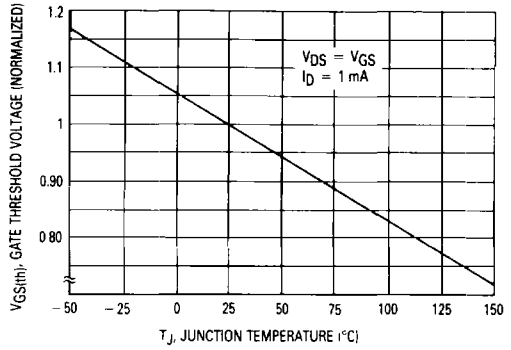


Figure 2. Gate-Threshold Voltage Variation With Temperature

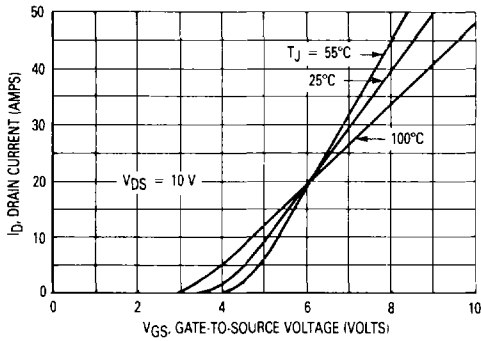


Figure 3. Transfer Characteristics

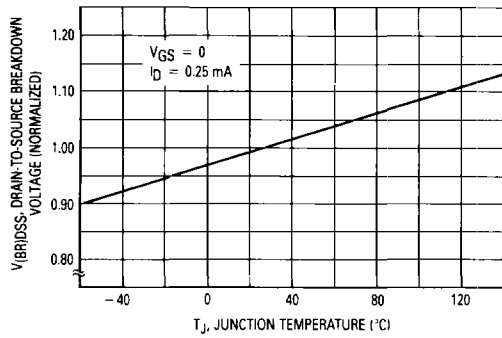


Figure 4. Breakdown Voltage Variation With Temperature

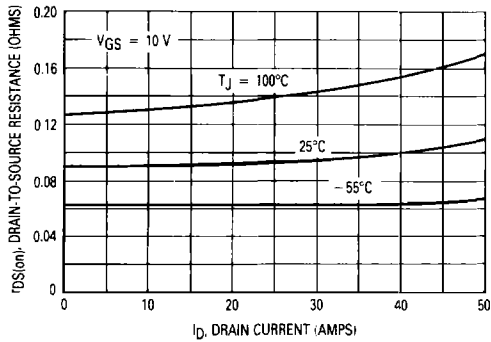


Figure 5. On-Resistance versus Drain Current

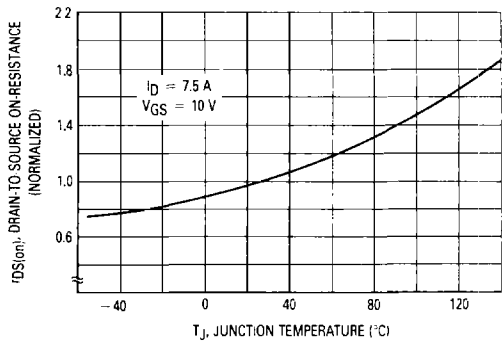


Figure 6. On-Resistance Variation With Temperature

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SAFE OPERATING AREA INFORMATION

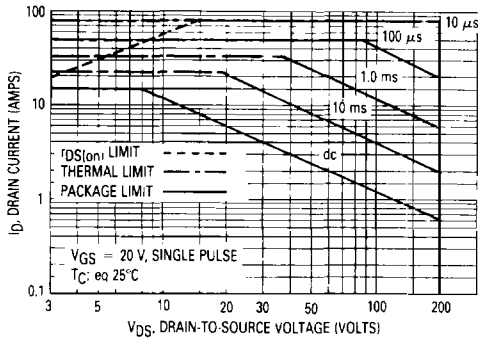


Figure 7. Maximum Rated Forward Biased Safe Operating Area

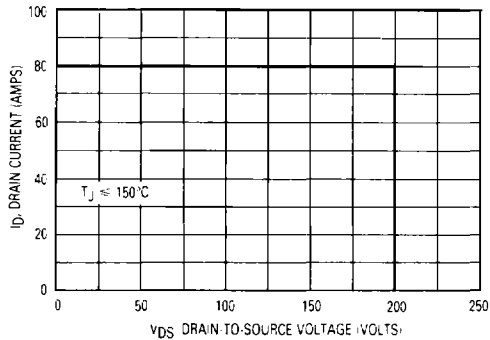


Figure 8. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V(BR)_{DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

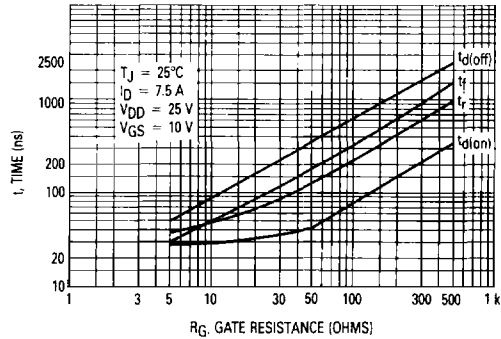


Figure 9. Resistive Switching Time Variation With Gate Resistance

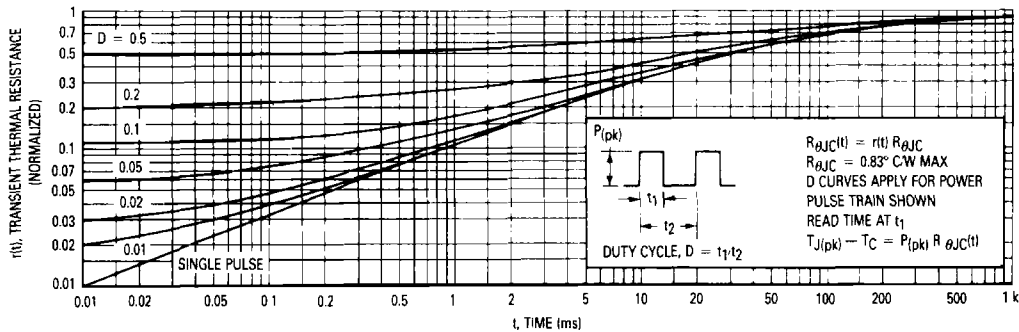


Figure 10. Thermal Response

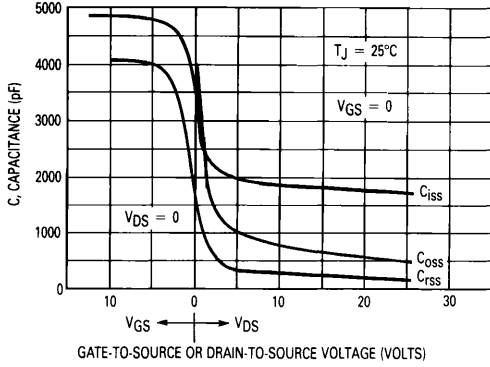


Figure 11. Capacitance Variation

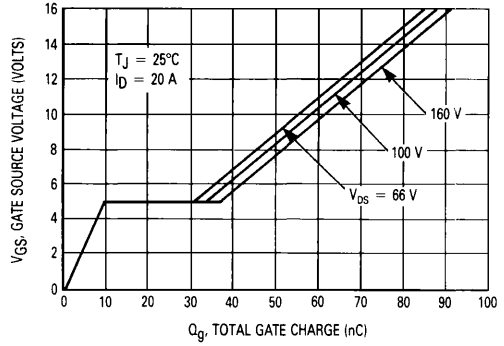


Figure 12. Gate Charge versus Gate-to-Source Voltage

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RESISTIVE SWITCHING

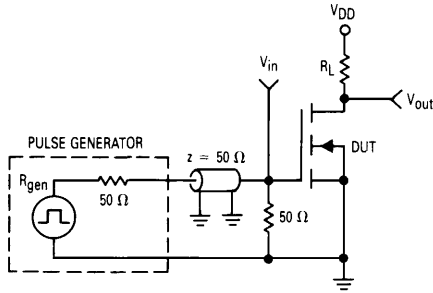


Figure 13. Switching Test Circuit

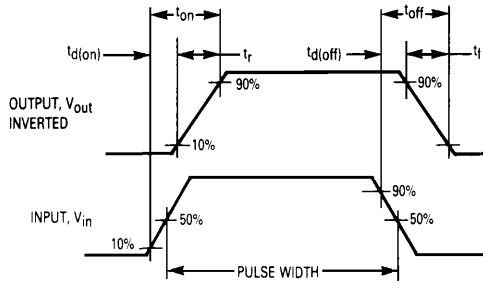


Figure 14. Switching Waveforms

OUTLINE DIMENSIONS

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	38.36	39.37	1.510	1.550
B	19.31	21.08	0.760	0.830
C	6.35	8.25	0.250	0.325
D	1.45	1.60	0.057	0.063
E	1.53	1.77	0.060	0.070
F	30.15	BSC	1.187	BSC
G	10.92	BSC	0.430	BSC
H	5.46	BSC	0.215	BSC
J	16.89	BSC	0.665	BSC
K	11.18	12.19	0.440	0.480
Q	3.84	4.19	0.151	0.165
R	25.15	26.67	0.990	1.050
U	3.84	4.19	0.151	0.165

STYLE 3:
PIN 1 GATE
2 SOURCE
CASE DRAIN

**CASE 197A-02
TO-204AE**

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	20.32	21.08	0.800	0.830
B	15.49	15.90	0.610	0.626
C	4.19	5.08	0.165	0.200
D	1.02	1.65	0.040	0.065
E	1.35	1.65	0.053	0.065
G	5.21	5.72	0.205	0.225
H	2.65	2.94	0.104	0.116
J	0.51	0.71	0.020	0.028
K	12.70	15.49	0.500	0.610
L	15.88	16.51	0.625	0.650
N	12.19	12.70	0.480	0.500
Q	4.04	4.22	0.159	0.166

STYLE 2:
PIN 1 GATE
2 DRAIN
3 SOURCE
4 DRAIN

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

**CASE 340-02
TO-218AC**